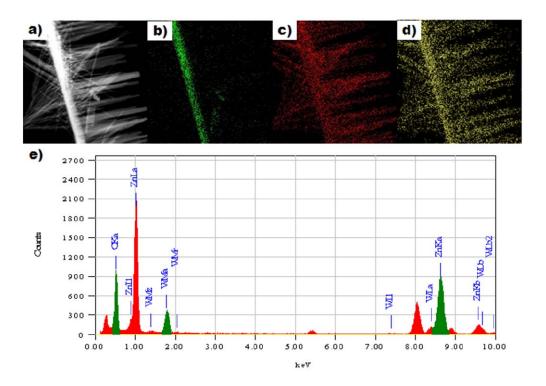
## **Supporting Information**

Fabrication of a novel hierarchical assembly of ZnO nanowires on WOx nanowhiskers for highly efficient field electron emission

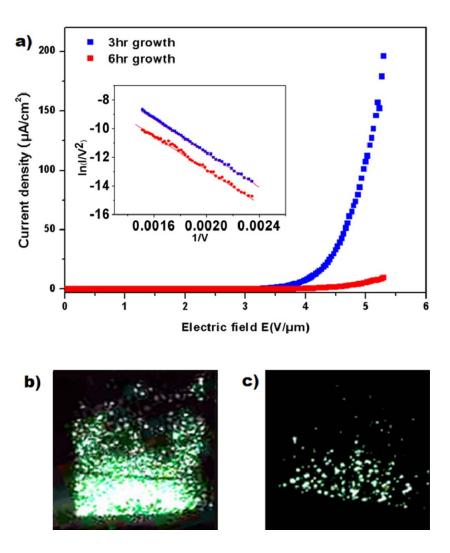
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**Fig.S1.** TEM analysis of the hierarchical ZnO/WOx heteronanostructures (a) A high angular annual dark field (HAADF) scanning TEM image of single hierarchical ZnO/WO<sub>x</sub> sample and scanning TEM-EDX elemental mapping images of (b) W, (c) Zn, and (d) O. (e) Energy dispersive spectra(EDS) recorded from the hierarchical ZnO/WOx heteronanostructures.



**Fig.S2.** Field-emission J-V curves: (a) ZnO nanowires/ $W_{18}O_{49}$  nanowhisker arrays on tungsten substrates with different growth times for the ZnO NWs (3 hr and 6 hr). The inset includes the FN plots of both samples. (b) and (c) depict the field emission images of samples grown in 3 hr and 6 hr, respectively.

Figure S2 depicts the field emission characteristics of the ZnO/WO<sub>x</sub> hierarchical nanostructures with different ZnO growth times of 3 hr and 4.5 hr at 95 °C using 10 mM Zn(NO<sub>3</sub>)<sub>2</sub> with an ammonia solution. Although the ZnO nanowires were grown for longer time duration, the field emission current was decreased as observed from these results. The obtained turn-on field voltages at 10 mA/cm<sup>2</sup> were estimated to be 4.1 and 4.6 Vµm<sup>-1</sup> for the samples that were grown at 3 hr and 4.5 hr, respectively. The reasons for the observed degradation in emission properties may be ascribed to screen effects due to an increased density of ZnO nanowires. A longer growth time produced ZnO nanowires having longer lengths with higher densities on the WO<sub>x</sub> nanowhiskers, as confirmed by the SEM images. The field emission images of both samples were taken at 0.8 kV (5.3Vµm<sup>-1</sup>). As seen in the field emission images of figure S2(b, c), the 3hr grown sample exhibited a brighter and more uniform emission in comparison to the 4.5 hr grown sample.